RENESAS

mos integrated circuit $\mu PD6222$

I²C-BUS COMPATIBLE 8BIT 12CHANNEL D/A CONVERTER

DESCRIPTION

The μ PD6222 is an 8-bit monolithic CMOS digital-to-analog converter using the R-2R technique. The μ PD6222 incorporates a 12-channel digital-to-analog converters and I²C-bus compatible interface. The designer needs only 2 signals (Serial Data and Serial Clock) to interface and can use 8-ICs (96-channels) on same bus to control chipselect terminals.

The μ PD6222 incorporates Output CMOS Buffer to achieve wide output voltage range and two reference voltage terminals.

The μ PD6222 is ideal for automatic control for color-television.

FEATURES

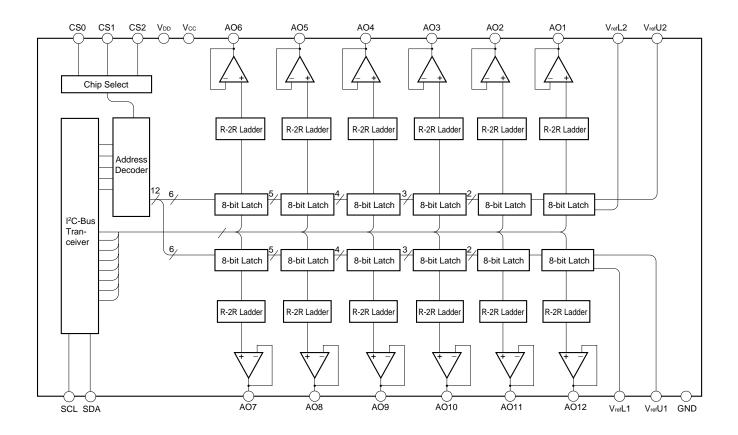
- 12-channel 8-bit digital-to-analog converter using the R-2R ladder technique
- I²C-bus compatible serial interface (Serial Data and Serial Clock)
- 8-ICs (96-channels) can be connected by chip-select terminals
- Output CMOS Buffer to achieve wide output voltage range
- Two reference voltage

ORDERING INFORMATION

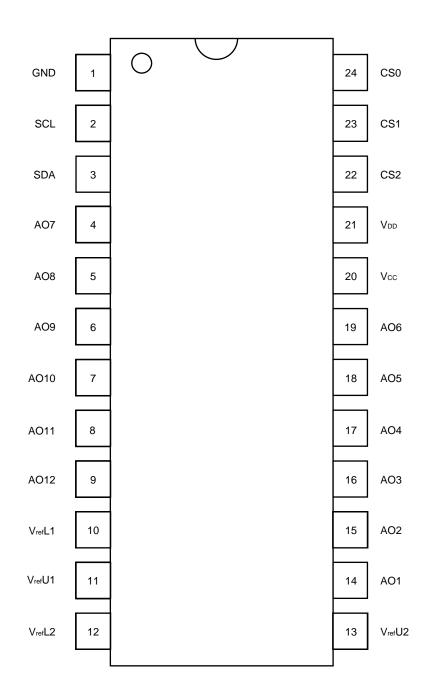
PART NO.	PACKAGE
μ PD6222CS	24-pin plastic shrink DIP (300 mil)
μ PD6222GS	24-pin plastic SOP (300 mil)

Caution Purchase of NEC I²C components conveys a license under the Philips I²C patent Right to use these components in an I²C system, provided that the system conforms to the I²C Standard Specification as defined by Philips.

BLOCK DIAGRAM



PIN CONNECTION DIAGRAM (Top View)



PIN CONFIGURATION

PIN NO.	SYMBOL	FUNCTION
1	GND	Ground
2	SCL	Serial Clock Input
3	SDA	Serial Data Input (Output: acknowledgement signal)
4	AO7	Analog Output Channel 7
5	AO8	Analog Output Channel 8
6	AO9	Analog Output Channel 9
7	AO10	Analog Output Channel 10
8	AO11	Analog Output Channel 11
9	AO12	Analog Output Channel 12
10	VrefL1	GND Side Reference Voltage Input 1 (The current of IrefL1 flows out from IC.)
11	V _{ref} U1	Vcc Side Reference Voltage Input 1 (The current of IrefU1 flows into IC.)
12	V _{ref} L2	GND Side Reference Voltage Input 2 (The current of IrefL2 flows out from IC.)
13	V _{ref} U2	Vcc Side Reference Voltage Input 2 (The current of IrefU2 flows into IC.)
14	AO1	Analog Output Channel 1
15	AO2	Analog Output Channel 2
16	AO3	Analog Output Channel 3
17	AO4	Analog Output Channel 4
18	AO5	Analog Output Channel 5
19	AO6	Analog Output Channel 6
20	Vcc	Analog Power Supply
21	Vdd	Digital Power Supply
22	CS2	Chip Select 2
23	CS1	Chip Select 1
24	CS0	Chip Select 0

Phase-out/Discontinued

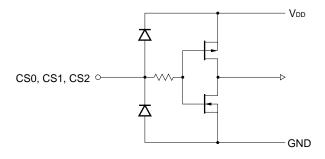
Note For "Power On Reset" function, when this IC is powered on, Analog Output Data (D0, D1 ... D7) will be set all 0. And the all Analog Output will be Zero Scale (1LSB + V_{ref}L).

NEC

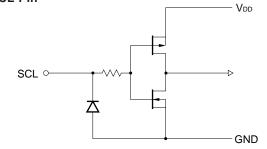
Phase-out/Discontinued

EQUIVALENT CIRCUIT OF PIN

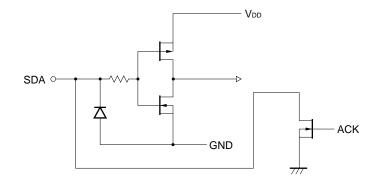
• Equivalent Circuit of CS0, CS1, CS2 Pins



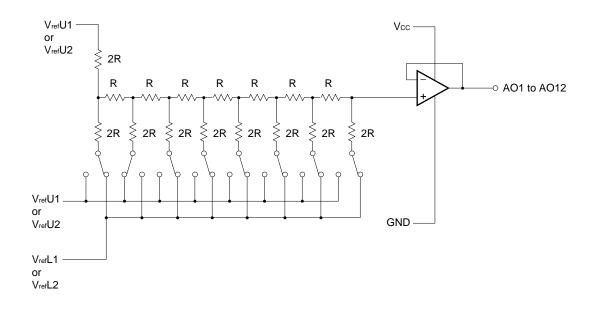
• Equivalent Circuit of SCL Pin



• Equivalent Circuit of SDA Pin



• Equivalent Circuit of VrefU1, VrefU2, VrefL1, VrefL2 and AO1 to 12 Pins



ABSOLUTE MAXIMUM RATINGS

PARAM	PARAMETER		LIMITS	UNIT
Digital Supply Voltage		Vdd	-0.3 to +7.0	V
Analog Supply Voltage		Vcc	-0.3 to V _{DD} + 0.3	V
Vcc Side Reference Vol	tage	V _{ref} U1, U2	-0.3 to Vcc + 0.3	V
GND Side Reference Vo	oltage	V _{ref} L1, L2	-0.3 to Vcc + 0.3	V
Digital Input Voltage	Digital Input Voltage		-0.3 to V _{DD} + 0.3	V
Output Voltage		Vout	-0.3 to Vcc + 0.3	V
Power Dissipation	CS Package	PD	500	mW
GS Package			200	mW
Operating Temperature Range		TA	-20 to +85	°C
Storage Temperature R	ange	Tstg	-55 to +125	°C

Phase-out/Discontinued

RECOMMENDED OPERATION CONDITIONS

PARAMETER	SYMBOL	CONDITION	MIN.	TYP.	MAX.	UNIT
Digital Supply Voltage	Vdd	Vdd = Vcc	4.5	5.0	5.5	V
Analog Supply Voltage	Vcc					
Input Voltage of Vcc Side Reference Voltage Range	V _{ref} U1, U2	This parameter is not same as D/A output voltage. D/A output is	VrefL		Vcc	V
Input Voltage of GND Side Reference Voltage Range	V _{ref} L1, L2	defined by the ability of Output Buffer Amp.	GND		VrefU	V
Output Capacitance Load	Co				0.1	μF

ELECTRICAL CHARACTERISTICS

DIGITAL BLOCK

(Vcc, Vdd, VrefU1, 2 = +4.5 to +5.5 V, VrefU1, 2 \leq Vcc, VrefL1, 2 = GND = 0 V, TA = -20 to +85 °C)

PARAMETER	SYMBOL	CONDITION	MIN.	TYP.	MAX.	UNIT
Digital Supply Current	ldd	CLK = 1 MHz, IAO = 0 μ A			1.0	mA
Input Leak Current	li leak	$V_{IN} = 0$ to V_{DD}	-10		10	μA
Low-Level Input Voltage	Vil				0.2 Vdd	V
High-Level Input Voltage	Vін		0.8 Vdd			V

Phase-out/Discontinued

ANALOG BLOCK

(Vcc, Vdd, VrefU1, 2 = +4.5 to +5.5 V, VrefU1, 2 \leq Vcc, VrefL1, 2 = GND = 0 V, TA = -20 to +85 °C)

PARAMETER	SYMBOL	CONDITION	MIN.	TYP.	MAX.	UNIT
Analog Supply Current	lcc	CLK = 1 MHz, IAO = 0 μ A		1.0	4.8	mA
Input Current of Vcc Side Reference Voltage	IrefU	V _{ref} U = 5 V, V _{ref} L = 0 V, Data: Maximum Current		1.2	3.0	mA
Output Voltage Range of	Vao	$I_{AO} = \pm 100 \ \mu A$	0.1		Vcc - 0.1	V
Output Buffer Amp.		$I_{AO} = \pm 500 \ \mu A$	0.2		Vcc - 0.2	
Output Current of Output	lao	VAO = 4.7 V			-1.0	mA
Buffer Amp.		VAO = 0.2 V	+1.0			
Differential Nonlinearity	Ndl	V _{ref} U = 4.79 V			±0.8	LSB
Nonlinearity	N∟	$V_{ref}L = 0.95 V$			±0.8	LSB
Zero Scale Error	Nz	Vcc = 5.5 V (15 mV/LSB) No Load (I _{AO} = 0 A)			±1.2	LSB
Full Scale Error	NF				±1.2	LSB
Error between each Channel	Nch				±1.2	LSB
Output Impedance of Output Buffer Amp.	Ro			5.0		Ω

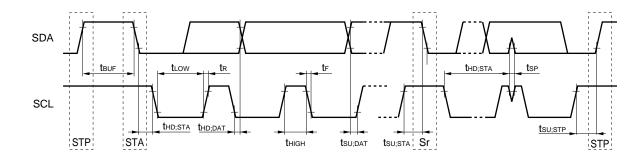
I²C-BUS TRANSFER STANDARD

PARAMETER	SYMBOL	MIN.	MAX.	UNIT
SCL clock frequency	fsc∟	0	100	kHz
Time the bus must be free before a new transmission can start	t BUF	4.7	-	μs
Hold time START condition. After this period, the first clock pulse is generated	thd;sta	4.0	-	μs
LOW period of the clock	tLOW	4.7	-	μs
HIGH period of the clock	tніgн	4.0	-	μs
Set-up time for START condition (Only relevant for a repeated START condition)	tsu;sta	4.7	-	μs
Hold time DATA for I ² C ICs	thd;dat	O ^{Note}	-	ns
Set-up time DATA	tsu;dat	250	-	ns
Rise time of both SDA and SCL lines	tR	-	1	μs
Fall time of both SDA and SCL lines	t⊧	-	300	ns
Set-up time for STOP condition	tsu;stp	4.0	-	μs

Phase-out/Discontinued

Note Note that a transmitter must internally provide at least a hold time to bridge the undefined region (max. 300 ns) of the falling edge of SCL.

Timing requirements for the I²C-bus



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Phase-out/Discontinued

I²C-BUS FORMAT

STA	SLAVE ADDRESS DATA	W	ACK	SUB ADDRESS DATA	ACK	D/A DATA	ACK	STP
-----	--------------------	---	-----	------------------	-----	----------	-----	-----

- STA: START condition
- W : This bit is a data-transfer direction bit. A 'Zero' (LOW) is set at sending a data from master to slave.
- ACK: This is an acknowledge bit. The receiver responses a 'Zero' (LOW) to the transmitter when the receiver acknowledges data reception.
- STP: STOP condition

DIGITAL DATA FORMAT

SLAVE ADDRESS DATA

First						Last	
MSB						LSB	
1	0	0	1	A2	A1	A0	
				Chip	Select	t Data	i

MSB	LSB

A2	A1	A0	CS2	CS1	CS0
0	0	0	0	0	0
0	0	1	0	0	1
0	1	0	0	1	0
÷	÷	÷	÷		÷
1	1	1	1	1	1

This chip will be selected only when A0, A1 and A2 are equal to CS0, CS1 and CS2.

•	SUB ADDRESS DATA	

First							Last
MSB							LSB
×	×	×	×	S3	S2	S1	S0
	Don't	care		Char	nel S	elect	Data

Channel	Select	Data
---------	--------	------

MSB			LSB	
S3	S2	S1	S0	Channel Select
0	0	0	0	Don't care
0	0	0	1	ch1
0	0	1	0	ch2
÷	÷	÷		:
1	0	1	1	ch11
1	1	0	0	ch12
1	1	0	1	Don't care
1	1	1	0	
1	1	1	1	Inhibit ^{Note}

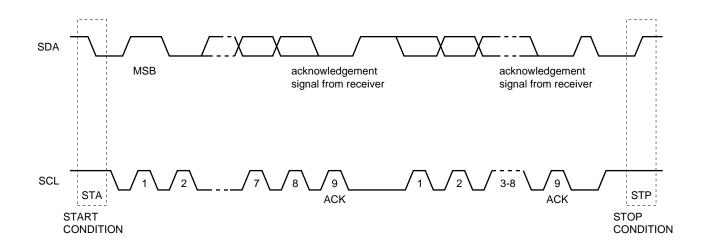
Note Internally Test Mode

• D/A DATA

First							Last
MSB							LSB
D7	D6	D5	D4	D3	D2	D1	D0

D/A Output Data								
First Last								
MSB							LSB	
D7	D6	D5	D4	D3	D2	D1	D0	D/A OUTPUT
0	0	0	0	0	0	0	0	$(V_{ref}U-V_{ref}L) \ / \ 256 \times 1 \ + \ V_{ref}L$
0	0	0	0	0	0	0	1	(V_{ref}U - V_{ref}L) / 256 \times 2 + V_{ref}L
0	0	0	0	0	0	1	0	(V_{ref}U - V_{ref}L) / 256 \times 3 + V_{ref}L
0	0	0	0	0	0	1	1	(V_{ref}U - V_{ref}L) / 256 \times 4 + V_{ref}L
÷	:	÷	:	÷	÷	÷	÷	
1	1	1	1	1	1	1	0	(VrefU - VrefL) / 256 \times 255 + VrefL
1	1	1	1	1	1	1	1	VrefU

DATA TRANSFER ON THE I²C-BUS



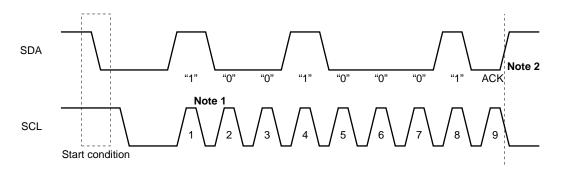
NEC

μ**PD6222**

I²C BUS ACCESS

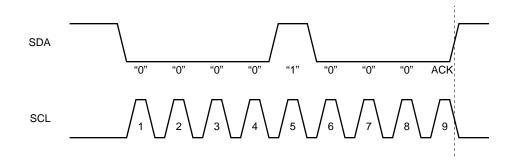
Data example; (CS2, CS1, CS0) = (A2, A1, A0) = (0, 0, 1) (S3, S2, S1, S0) = (0, 1, 0, 0) Select output 4ch Digital Data = (0, 1, 0, 1, 0, 1, 0, 1)

SLAVE ADDRESS DATA BLOCK

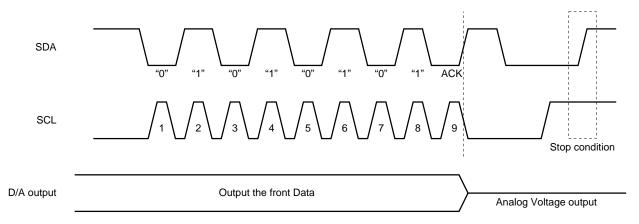


Phase-out/Discontinued

SUB ADDRESS DATA BLOCK



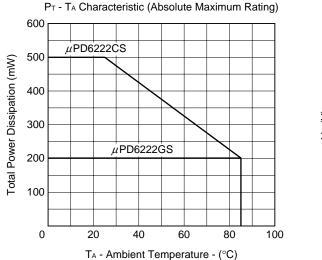
D/A DATA BLOCK

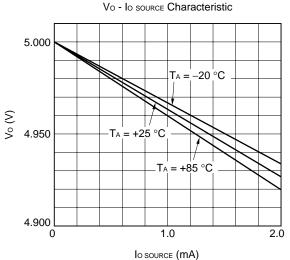


- Notes 1. The timing of reading data in SDA is the falling edge of SCL.
 - 2. The acknowledgement signal is output from SDA in fall-timing of SCL8, and releases SDA line in the fall-timing of SCL9.

CHARACTERISTICS CURVES (TYP.)

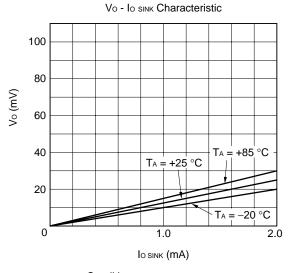
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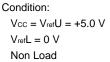




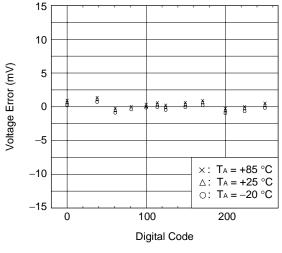
Condition: Vcc = $V_{ref}U$ = +5.0 V





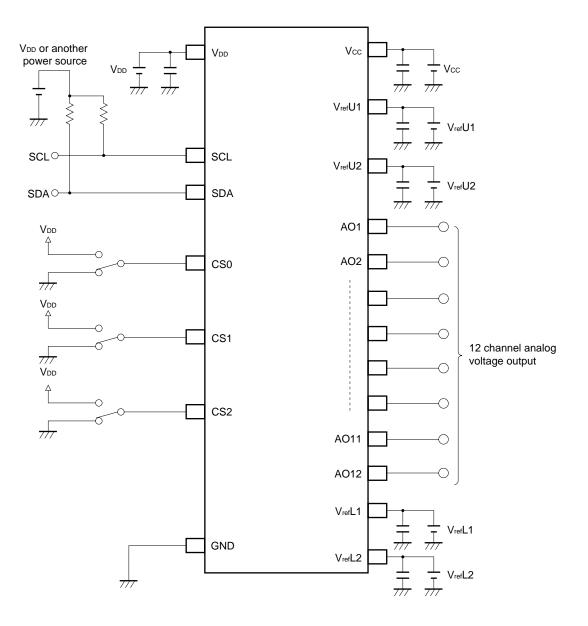


Liniarity of D/A Output



Condition: $V_{CC} = +5.5 V$ $V_{ref}U = +4.79 V$ $V_{ref}L = +0.95 V (15 mV/LSB)$ Non Load

APPLICATION EXAMPLE



NOTE FOR USE

ABOUT INPUT VOLTAGE

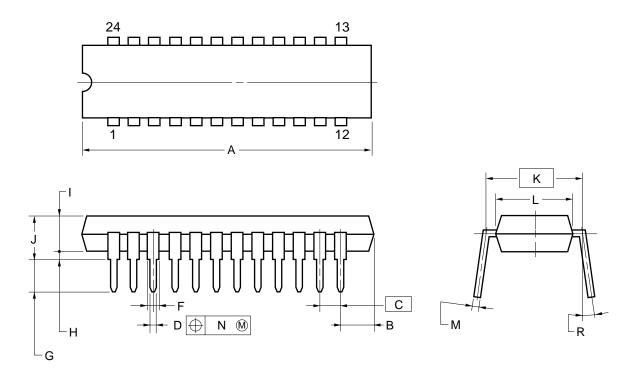
This IC's V_{DD}, V_{CC}, V_{ref}U1, V_{ref}U2, V_{ref}L1, V_{ref}L2 pins must be supplied the stable voltage. When the voltagelevel of these pins are added any noise signal, the analog accuracy of output voltage may be influenced by any noise signal.

Therefore, the bypass condenser is connected between these pins and GND pins for keeping the analog accuracy. And it's necessary that the bypass condenser is near IC.

• HANDLING RELATED TO THE UNUSED PINS

The output pins have a possibility of being unused pins. If there are unused pins, they must not be connected.

24PIN PLASTIC SHRINK DIP (300 mil)



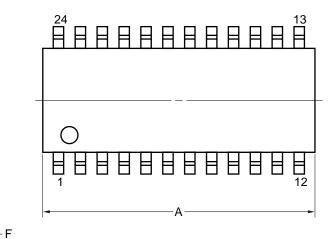
NOTES

- 1) Each lead centerline is located within 0.17 mm (0.007 inch) of its true position (T.P.) at maximum material condition.
- 2) Item "K" to center of leads when formed parallel.

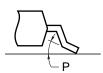
ITEM	MILLIMETERS	INCHES
А	25.40 MAX.	1.000 MAX.
В	3.0 MAX.	0.119 MAX.
С	1.778 (T.P.)	0.070 (T.P.)
D	0.50±0.10	$0.020^{+0.004}_{-0.005}$
F	0.85 MIN.	0.033 MIN.
G	3.5±0.3	0.138±0.012
н	0.51 MIN.	0.020 MIN.
I	4.31 MAX.	0.170 MAX.
J	5.08 MAX.	0.200 MAX.
К	7.62 (T.P.)	0.300 (T.P.)
L	6.4	0.252
М	$0.25^{+0.10}_{-0.05}$	$0.010\substack{+0.004\\-0.003}$
Ν	0.17	0.007
R	0~15	0~15

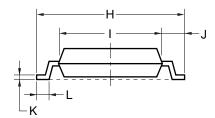
B S

24 PIN PLASTIC SOP (300 mil)



detail of lead end





NOTE

-G

- E

1. Controlling dimension — millimeter.

D

С

MM

2. Each lead centerline is located within 0.12 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

□ N

S

ITEM	MILLIMETERS	INCHES
А	15.3±0.24	0.602±0.010
В	0.78 MAX.	0.031 MAX.
С	1.27 (T.P.)	0.050 (T.P.)
D	$0.40^{+0.10}_{-0.05}$	$0.016\substack{+0.004\\-0.003}$
Е	0.1±0.1	0.004±0.004
F	1.8 MAX.	0.071 MAX.
G	1.55±0.05	0.061±0.002
Н	7.7±0.3	0.303±0.012
I	5.6±0.15	$0.220^{+0.007}_{-0.006}$
J	1.05±0.2	$0.041^{+0.009}_{-0.008}$
к	$0.22^{+0.08}_{-0.07}$	$0.009^{+0.003}_{-0.004}$
L	0.6±0.2	$0.024^{+0.008}_{-0.009}$
М	0.12	0.005
Ν	0.10	0.004
Р	3° ^{+7°} -3°	3° ^{+7°} -3°

P24GM-50-300B-5

RECOMMENDED SOLDERING CONDITIONS

The following conditions (see tables below) must be met when soldering this product.

Phase-out/Discontinued

Please consult with our sales offices in case other soldering process is used, or in case other soldering is done under different conditions.

TYPES OF SURFACE MOUNT DEVICE

For more details, refer to our document "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (IEI-1207).

[µPD6222GS]

Soldering method	Soldering conditions	Recommended condition symbol
Infrared ray reflow	Peak package's surface temperature: 235 °C or below, Reflow time: 30 seconds or below (210 °C or higher), Number of reflow process: 3, Exposure limit ^{Note} : None	IR35-00-3
VPS	Peak package's surface temperature: 215 °C or below, Reflow time: 40 seconds or below (200 °C or higher), Number of reflow process: 2, Exposure limit ^{Note} : None	VP15-00-2
Wave soldering	Solder temperature: 260 °C or below, Flow time: 10 seconds or below, Number of flow process: 1, Exposure limit ^{Note} : None	WS60-00-1
Partial heating method	Terminal temperature: 300 °C or below, Flow time: 3 seconds or below, Exposure limit ^{Note} : None	

Note Exposure limit before soldering after dry-pack package is opened. Storage conditions: 25 °C and relative humidity at 65 % or less.

Caution Do not apply more than a single process at once, except for "Partial heating method".

TYPES OF THROUGH HOLE DEVICE

[µPD6222CS]

Soldering method	Soldering conditions	Recommended condition symbol
Wave soldering	Solder temperature: 260 °C or below, Flow time: 10 seconds or below	

REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system	IEI-1212
Quality grade on NEC semiconductor devices	C11531E
Semiconductor device mounting technology manual	C10535E
NEC IC Package Manual (CD-ROM)	C13388E
Guide to quality assurance for semiconductor devices	MEI-1202
Semiconductor selection guide	X10679E

[MEMO]

-NOTES FOR CMOS DEVICES-

1 PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note: Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

(2) HANDLING OF UNUSED INPUT PINS FOR MOS DEVICES

Note: No connection for MOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. MOS device behaves differently than Bipolar device. Input levels of MOS device must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note: Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

[MEMO]

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While NEC Corporation has been making continuous effort to enhance the reliability of its semiconductor devices, the possibility of defects cannot be eliminated entirely. To minimize risks of damage or injury to persons or property arising from a defect in an NEC semiconductor device, customers must incorporate sufficient safety measures in its design, such as redundancy, fire-containment, and anti-failure features.

NEC devices are classified into the following three quality grades:

"Standard", "Special", and "Specific". The Specific quality grade applies only to devices developed based on a customer designated "quality assurance program" for a specific application. The recommended applications of a device depend on its quality grade, as indicated below. Customers must check the quality grade of each device before using it in a particular application.

- Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
- Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
- Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices is "Standard" unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact an NEC sales representative in advance.

Anti-radioactive design is not implemented in this product.

M4 96.5